

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10576220	LEE ET AL.
Examiner	Art Unit	
	MARCOS BATISTA	2617

SEARCHED

Class	Subclass	Date	Examiner
455	466	2/14/2008	mb
455	95	2/14/2008	mb

SEARCH NOTES

Search Notes	Date	Examiner
Consulted with Steve D'Agosta	2/19/2008	mb
Consulted with TA - Yogesh Aggarwal	2/14/2008	mb
Consulted with Lun-Yi Lao	2/19/2008	mb
East Search	2/14/2008	mb
Inventor's Name Seach	2/14/2008	mb
East Search	12/5/2008	mb
Consulted with Rafael Perez Gutierrez	12/4/2008	mb
East Search	6/27/2009	mb
Consulted with Rafael Perez Gutierrez	6/29/2009	mb

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
455	all	6/29/2009	mb
370	all	6/29/2009	mb